

<b>Notice of References Cited</b>	Application/Control No. 10/625,167		Applicant(s)/Patent Under Reexamination SCHIFF ET AL.	
	Examiner Raymond S. Dean		Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,198,730	03-2001	Hogberg et al.	370/320
*	B	US-6,925,113	08-2005	Kim et al.	375/227
*	C	US-2003/0050008	03-2003	Patterson et al.	455/12.1
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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